This paper discusses novel methodologies for the characterization of harmonic signals generated by wireless powered devices, i.e. passive ultra-high frequency (UHF) radio frequency identification (RFID) tags, due to the wireless power transferred from reader to tag. Theoretical aspects, as well as measurements to characterize these non-linear phenomena are exposed. Particular care is taken to explain the analysis methodology and setup for two kinds of characterization measurements: radiated and conducted. The existence of harmonic signals carrying information is exploited in an advanced application example. A dual-band RFID tag is designed to increase the backscattered harmonic level in the tag-to-reader link. Measurement of this dual band tag demonstrates the exploitation of the hitherto neglected harmonic power; it also opens the door to more advanced applications exploiting the harmonic-link communication.

Keywords: Wireless power transfer, Harvesting, Passive RFID, Harmonic balance, RFID and sensors, Antennas and propagation for wireless systems, Antenna design, Modeling and measurements, Microwave measurements

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I. INTRODUCTION

Wireless power transmission (WPT), electromagnetic energy harvesting (EEH), and passive radio frequency identification (RFID) are three complementary technologies in the context of Internet-of-Things era [1, 2]. A particular case that exploits WPT is the passive RFID technology, being so far not limited to identification but extends to sensing applications. This evolution transforms the RFID into a cornerstone technology for the ubiquitous wireless sensor networks. Regarding WPT operation, the element responsible of harvesting electromagnetic energy and converting it into direct current (DC) power to feed a battery-less device and/or attached sensor is the rectifier antenna, commonly named in the literature as rectenna [3].

Designs of these rectifying antennas for WPT and EEH are widely explained in the literature for a single-frequency band [4, 5], dual-frequency band [6, 7], or even for wide frequency band [8, 9]. Most of the rectennas are designed at the Industrial Scientific and Medical (ISM) band, Global System for Mobile Communications (GSM) band, Universal Mobile Telecommunications System (UMTS) band, or millimeter wave band. However, regardless the frequency of these designs, only little attention has been paid the harmonic power generated by the rectennas [10]. Indeed, the harmonic production phenomenon is generated by the rectifying operation of the circuit composed by non-linear devices. The phenomenon can be defined as harmonics in WPT (H-WPT). The architecture of rectifier circuits is based on the Cockcroft-Walton topology, with two or more diode-based voltage-doubler stages. The study case presented in this paper focuses on a similar architecture found in passive UHF RFID tags. Actually, the tag antenna is loaded by an integrated circuit, hereinafter called RFID chip. One of the tasks that the RFID chip performs is precisely the rectification operations that convert the alternating current (AC) of the RF waves sent by the reader into a DC power, thus allowing the chip to perform its other duties as transponder. These diodes determine the non-linear behavior of rectifier circuits, or RFID chips in this paper [11–13].

Figure 1 highlights the rectenna section as part of the passive RFID tag architecture. Three common parts for all WPT devices can be distinguished in the rectenna section: (1) the antenna, (2) the N-stage rectifier circuit, and (3) the antenna-rectifier impedance matching network.

This paper reviews the state-of-the-art of H-WPT in the passive UHF RFID case and the possible exploitation of the wasted energy naturally produced during the rectification process performed by the RFID chip. Theory behind the harmonic generation as well as the characterization methods to evaluate the non-linear phenomena are presented.

In the application part, the power contained in the harmonic signals produced by RFID chips is used to preserve
the energy-harvesting concept. The idea is to introduce diversity in frequency into the traditional operation of passive UHF RFID tags by profiting from the harmonic power to increase the harmonic backscattering. The optimized design of a dual-band RFID tag antenna, which radiates the fundamental signal and a harmonic signal, is presented and results are discussed.

Section II explains the harmonic production phenomena present in the WPT operation of passive RFID tags, and unfolds two characterization methods used to evaluate its non-linear behavior. Section III presents the application example by designing a dual-band tag antenna to implement diversity in frequency. Experimental results are also discussed. Finally, in Section IV some conclusions are drawn.

II. HARMONICS IN PASSIVE UHF RFID

Although rectennas used for EEH and passive RFID tags have similar RF section, there is a small but crucial difference on the non-linear treatment. Because of the non-linearity behavior of the diodes used in the rectifier, appropriate techniques of simulation and optimization are used in those circuit designs. The harmonic balance (HB) is a simulation method that considers the effect of the harmonic currents produced by non-linear devices [14]. In the rectenna case, the RF currents flow to the DC section and to antenna terminals. If they are well filtered in the DC section side, a good DC signal can be achieved at the output, and then an enhanced RF-to-DC conversion efficiency is obtained [14–16]. The phenomena can be simulated with the HB method, being possible to predict and to control the behavior of the complete rectenna, both in the DC section and in the antenna. In passive UHF RFID chips, the harmonics reflected through the DC section are surely treated in the process of chip design, and then an optimal DC signal feeds the digital section of the chip. However, the harmonics are reflected through the antenna since no harmonic treatment consideration is performed on the RFID antenna design. Antenna design in passive RFID tags begins directly from the knowledge of the chip impedance at the fundamental frequency provided by data sheets [17, 18]. Summarizing, the design process aims to ensure impedance matching at the frequency of operation, but the antenna-chip matching behavior around harmonic frequencies is unknown. As long as antenna and chip are independently designed [17, 19], the antenna can radiate some of the harmonic currents generated by the rectifier, which finally triggers in harmonic backscattering [13, 20].

Figure 2 shows the harmonic current distributions on a half-wave dipole antenna structure operating at fundamental frequency. For traditional RFID tag antennas based on half wave dipoles it should be noted as expected, that odd harmonic responses will be higher compared to even ones.

To perform a qualitative analysis about the power strength of harmonic signals produced by passive RFID chips, specific characterization methods are needed.

Several characterization platforms for passive UHF RFID have been proposed in the literature. For example in [21–27] techniques to evaluate the performance of chip–antenna integration are proposed, contrary to [22, 25–27]
the impedance matching is strictly evaluated. In [23–26] techniques to measure the differential radar cross-section (ΔRCS) and sensitivity of RFID tags are proposed.

In this paper, two characterization methods to evaluate the strength of harmonic signals in passive RFID are discussed. The first one is based on radiated measurements performed over complete RFID tags, the second one is based on conducted measurements performed directly over RFID chips. The methods are valid to perform accurate measurements in a wide frequency range including harmonics, and having the chip activated.

A) Radiating measurements

1) Setup, methods, and metrics
A technique used to characterize the harmonics produced by passive UHF RFID tags was presented in [13]. The analysis procedure of harmonic responses is based on radiated measurements. The RFID communication between the RFID test-bench and the tag is established and simultaneously, a power spectral density (PSD) analysis is performed over time domain communication signals. The fast Fourier transform (FFT) calculation is made over the carrier wave (CW) portion after the Query command is sent. In case of tag response, the PSD analysis shows side lobes around the carrier like a typical spectrum of square waves as consequence of the modulated information. The conceptual procedure of the method is represented in Fig. 3.

One of the major contributions of the method [13] is to highlight the characteristics of the backscattering modulation to clearly interpret the time-domain signals and its PSD calculation. The PSD analysis considers the configuration of the RFID air interface to produce a periodic sequence of bits on the tag response [28]. Indeed, characteristics as backscattering link frequency (BLF), data encoding and preamble are pre-configured on the treatment of the physical layer in the UHF RFID communication. Regarding the setup, measurements were done in an anechoic chamber specially prepared for bi-static configuration offering a partition wall of 48 dB isolation between horn antennas, thus minimizing the mutual coupling. The setup is shown in Fig. 4. As a result, the passive RFID tag response level is quantified at the fundamental frequency and its harmonics.

2) Results
The first part of the analysis measures the sensitivity from five different commercial tag inlays. Table 1 shows detailed results. Considering each tag sensitivity, Fig. 5 shows the level of the backscatter response, for the fundamental frequency and its harmonics. In all cases, besides the fundamental frequency, the 3rd harmonic response is predominant among the remaining, reaching in the higher case $-86$ dBm. Representative results (2nd and 3rd harmonic) are summarized in Table 2.

![Fig. 3. Conceptual procedure based on PSD analysis of UHF RFID signals [13].](image)

![Fig. 4. (a) Setup distribution in the anechoic chamber. (b) Equipment setup for bi-static configuration.](image)

![Fig. 5. PSD of the tag response. The values are taken at the activation threshold of each tag at the fundamental frequency.](image)

<table>
<thead>
<tr>
<th>Table 1. Measured sensitivity of tags under test.</th>
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<th>Table 2. Harmonics of the tag response.</th>
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B) Conducted measurement

1) Setup, Methods, and Metrics

An RFID Test Platform (RFID-TP) for conducted measurements performed directly over RFID chips was presented in [34]. This platform complements the radiated measurement exposed above, offering a complete non-linear characterization for passive tags. The RFID-TP enables to perform accurate measurements, when the RFID chip is activated, in a wide frequency range that includes harmonics. The main difference with respect to radiate measurements is the direct connection of the RFID chip to the measurement system RFID-TP. This technique allows the characterization of different types of chip, and avoids to consider the effect of fixed tag antenna structures. Unlike the radiated measurement method presented in Section II-A, conducted measurement includes a vectorial characterization, which is one of the major contributions of this method. Indeed, thanks to this method it is possible to measure both complex impedance modulation states (scavenging and reflecting) in a wide range of frequencies, even at the harmonic frequencies.

Regarding the composition of the RFID-TP, the block diagram setup is shown in Fig. 6. Two main parts are highlighted. The first one consists on specialized equipments for microwave measurements and named “RFID tester”. The second one is composed by two impedance tuners connected in series with the fixture that holds the RFID chip and named “antenna impedance emulator”. With the described configuration, a complete characterization can be performed under full communication between RFID-TP and chip. The setup depicted in Fig. 7 is briefly described below. Further details can be found in [34].

- **RFID tester**: An Agilent N5224A Programmable Network Analyzer (PNA) is used to generate the Query command by using an external source [35]. The external source is a Vector Signal Generator (VSG) with a 20 dB low pass filter (LPF) at its output, to ensure that the chip harmonic response is self-generated. After the Query command is sent, the PNA determines the chip impedance during scavenging and reflecting states over a temporal sweep at the frequencies of interest [13]. A Digital Storage Oscilloscope (DSO) also connected to the chip allows the visualization of the modulated response. Additionally, the PSD analysis is performed over the time window to assess the response of the chip [28]. Finally the control of the RFID-TP is made by a Matlab program running on the host PC.

- **Antenna Impedance Emulator**: It is composed by two impedance tuners connected in series to provide matching between the 50 Ω RFID tester and the chip. The RFID chips were fixed over 50 Ω SMA connectors [26]. When the matching is achieved (by setting the tuner positions), the chip is in scavenging state and once activated, it switches between its two modulation states. Details are presented in [36].

Under this operation, Fig. 8 shows an experimental example of the PSD analysis in the DSO, in a frame where the scavenging matching condition was achieved and the chip responds. The side lobes due to the modulated response are shown for the fundamental, 2nd and 3rd harmonics.
2) RESULTS

Using the conducted method described above, harmonic characterization for three commercial RFID chips is reported. The chips are (1) G2XM NXP SOT505-1 [37], (2) G2XM NXP SOT1040-AA1 [37] with strap, and (3) Impinj Monza 5 [18] extracted from a commercial inlay AKtag [38].

The harmonic response level was measured for the three chips from the fundamental frequency until the 4th harmonic, by performing the PSD analysis over the same response frame in all cases. Results are shown in Fig. 9. As already discussed in Section II-A, the 3rd harmonic is predominant for all chips under test. It is worth noting that a backscatter response is detected even at the 4th harmonic for an input power above 3 dBm in the case of chips 1 and 3. Details about the harmonic responses at the activation power are shown in Table 3.

Since vectorial characterization is included in this method, the measurement of the impedance modulation is possible, while the chip is activated. Figure 10 shows the input impedance of the chip 1 in both modulation states for the fundamental and its 3rd harmonic. At the 3rd harmonic, the resistive part decreases and the reactance becomes more capacitive compared with the impedance at the fundamental frequency. Moreover, the difference between both modulation states is lower which means in a radiating scenario, that the $\Delta \text{RCS}$ [39] will be smaller than that one at the fundamental frequency.

The characterization platforms above exposed, write down a new line on the state-of-the-art of the passive RFID technology, especially for what concerns the intrinsic non-linear phenomena that occur in WPT operations, i.e. H-WPT. With the new characterization tools, the power carried by harmonics generated by passive RFID chips is evidenced. It is worth noting that harmonic signals are also carrying the modulated information.

Hereafter, given the redundant information originated on the same chip, a new application example makes use of this energy. The design of an RFID tag antenna radiating the 3rd harmonic besides the fundamental signal is proposed.

III. APPLICATION EXAMPLE

This section presents an application example that uses the harmonic power generated by passive UHF RFID chips. The design of a harmonic tag (HT) with the following requirements is envisaged [40–42]:

- **Frequency band.** Dual-band operation is required: at the fundamental frequency of 915 MHz and its 3rd harmonic 2745 MHz.
- **Structure.** A direct and fast prototyping is desired. The tag will remain as simple as possible based on printed dipoles in order to exhibit omnidirectional behavior.
- **Read range.** A maximum read range is desired under the local regulations. The antenna-chip matching is optimized to ensure the tag performance. Regarding the polarization, reader and tag antennas are oriented for the maximum polarization matching.
- **Application.** It concerns on the use of the energy contained on the 3rd harmonic self-generated by a passive RFID chip. It is envisaged to enhance the harmonic backscattered level by designing a specific HT.
- **Cost.** A low-cost prototype is desired. The materials are paper substrate with relative dielectric permittivity of 2.31 and thickness of 1 mm, copper tape and an available commercial loop-shape tag.

A) Modeling

1) SINGLE-BAND ANTENNA

Initially as a comparative reference, a single-band dipole antenna (SDA) for a conventional operation at 915 MHz was designed (Fig. 11). For the conjugate impedance matching, the method of inductively coupled loop was used. The method considers a radiating dipole inductively fed via a coupled small loop [43–44]. For practical reasons, the commercial AKTAG inlay tag [38] is used as inductive loop.
From conducted measurements, the imaginary parts of the antenna that conjugate the impedance of the chip at fundamental and its 3rd harmonic are 148 and 39 Ω respectively, whereas the optimum real parts are approximately 15 Ω in both bands.

2) DUAL-BAND ANTENNA
With the purpose to enhance the 3rd harmonic backscatter signal, a second antenna called dual-band dipole antenna (DDA) was designed (Fig. 11). The DDA uses a coplanar parasitic element, which lies parallel to the driving dipole. The parasitic element and the driving dipole have different resonant lengths for the fundamental frequency and its 3rd harmonic, respectively. The parasitic element is fed by the driving dipole being a coupling distance “C”, which yields it to the resonance [45, 46].

3) IMPEDANCE MATCHING CONSIDERATIONS
The arrangement of each antenna (SDA or DDA) with the AKTAG loop, whose terminals are directly connected to the chip, adds an equivalent inductance to the antenna. The strength of coupling and therefore of the added reactance, is controlled by varying the distance between the loop and the antenna. It is important to note that the mutual coupling and therefore the total input resistance of the SDA or DDA is dependent on: (1) the loop shape that is in this case fixed and (2), on the SDA–loop distance. On the other hand, the reactance is mainly affected by the loop design [43]. The distance “C” plays a key role for the reactance and the resistance of the DDA for the 3rd harmonic frequency. The proposed designs are etched on paper substrate. The configuration of the proposed SDA RFID and DDA RFID tags is shown in Fig. 11. Table 4 summarizes all the design parameters.

Some basic assumptions for the simulation carried out in CST Microwave-Studio are described below:

- The inductive coupling and the resulting input impedance seen from the loop terminals are fixed and assumed to be optimal from the commercial AKTAG design.
- The DDA design was done initially separately from the AKTAG loop considering the feeding point on the middle of the driving dipole. As a second step, the loop

<table>
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<tr>
<th>Parameter</th>
<th>SDA (mm)</th>
<th>DDA (mm)</th>
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<tr>
<td>L1</td>
<td>194.0</td>
<td>180.0</td>
</tr>
<tr>
<td>L3</td>
<td>–</td>
<td>37.3</td>
</tr>
<tr>
<td>W1</td>
<td>1.2</td>
<td>1.3</td>
</tr>
<tr>
<td>W3</td>
<td>–</td>
<td>2.0</td>
</tr>
<tr>
<td>C</td>
<td>–</td>
<td>2.9</td>
</tr>
<tr>
<td>D</td>
<td>0.2</td>
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Fig. 11. SDA and DDA tag prototypes.

Table 4. Dimensions of tags SDA and DDA.

Fig. 12. Simulated input impedance for the SDA and DDA at the fundamental frequency.

Fig. 13. Simulated input impedance for the SDA and DDA at the 3rd harmonic frequency.
model including its adhesive package, is introduced in the simulation with the real feeding point on the loop.

- To optimize the coupling DDA-loop, the distance between both elements is optimized considering the chip impedance measured at fundamental frequency and the 3rd harmonic frequency.
- All the electrical features of the used low cost materials were considered in the simulations.

Performance results about the SDA and DDA tags are depicted below. Figures 12 and 13 show the simulated resistance and reactance of the SDA and DDA at fundamental frequency and its 3rd harmonic, respectively. The impedance around the fundamental frequency and its 3rd harmonic are closely the conjugate of the chip impedance. Simulated return loss of antennas is depicted in Figs 14 and 15 for the fundamental frequency and its 3rd harmonic, respectively. The impedance bandwidth for the DDA at 915 MHz is 4.46%, and at 2745 MHz, it is 1.70%.

The simulated realized gain patterns in the H-plane at 915 and 2745 MHz are depicted in Figs 16 and 17, respectively, for the SDA and DDA tags. It is shown that the pattern at the fundamental frequency and its 3rd harmonic are comparatively featured more close to an omni-direction pattern. The simulated realized gains at 915 MHz and at 2745 MHz are 2.54 and 1.45 dBi, respectively.

**B) Experimental results**

For the prototyping of the SDA and DDA RFID tags, a technique called cutting plotter-based tag prototyping on flexible adhesive copper sheets (CPFACS) [47–49] suitable for cost-effective, time-saving, and high-performance is used. The CPFACS prototype is finally joined with the commercial loop tag.

With the radiated measurement method presented in Section II-A, the SDA and DDA tag prototypes were evaluated. Figure 18 compares the SDA and DDA tag performances at the 3rd harmonic frequency. The goal of enhancing the harmonic backscatter level is accomplished. An improvement of 15.62 dB on the 3rd harmonic backscatter level coming from the DDA is measured with respect to the SDA. The experiment confirms that the 3rd harmonic power can be efficiently radiated by properly tag antenna design. It is important to note the higher carrier level (main central lobe) for the DDA in Fig. 18. This effect stands out the impedance matching condition at the harmonic frequency, since the harmonic carrier is self-generated by the chip. Figure 19 compares the PSD of the tag response until the 5th harmonic for tags T5, SDA, and DDA. The tag DDA has a 3rd harmonic response 10 dB higher than that one coming from the tag T5.

Two important achievements can be highlighted from the presented example: (1) the use of the commercial AKTAG loop allows us to simulate simple antenna structures, which triggers in light simulations, and fast prototyping; (2) regarding the performance of the solution, it has been demonstrated the feasibility of the harmonic energy recycling. The DDA is able to maintain a traditional RFID communication at 915 MHz with the reader, and at the same time to produce a redundant signal at its 3rd harmonic frequency. The
The redundant backscatter harmonic is 10 dB higher than that one from the commercial tag T5. However, the enhancement is achieved at the expense of a 6 dB reduction on the tag response level at the fundamental frequency. The impedance matching condition achieved at the 3rd harmonic degrades the matching condition at the fundamental frequency, which consequently triggers in (1) a reduction of the tag sensitivity, and (2) a reduction of its response strength, congruent with experimental results for harmonic treatments reported in [34]. Nevertheless, the global read range of the HT will be limited by the harmonic strength, which in all cases is smaller than that one at the fundamental frequency. Considering only one receptor, the global read range of the HT will depend on the receptor sensitivity at the harmonic frequency.

IV. CONCLUDING REMARKS

This paper presents novel methodologies for the characterization of harmonics generated by harvester devices and considers their application to the passive RFID tags case. The efficient treatment of harmonics allows us to establish a redundant communication from tag to reader in the traditional passive RFID technology. Early studies have treated the non-linearity of the RFID chip as a spurious effect while ensuring the matching between antenna and chip at certain level of power at the fundamental frequency [11]. It is worth noting that the non-linearity, in uncontrolled conditions, is certainly destructive and has negative impact on the performance of the system. More recently, studies demonstrate that the non-linearity effect exists in normal operation conditions, and it generates a 3rd harmonic backscatter signal that carries information. Experimental results have shown that proper antenna design can increase the harmonic backscatter level of passive RFID tags. A new HT based on a dual-dipole antenna has increased the level of the 3rd harmonic backscatter signal by 10 dB. However, the impedance matching condition achieved at the 3rd harmonic degrades the matching condition at the fundamental frequency, resulting in a reduction of the response level at the fundamental frequency but without limiting the global performance of the harmonic tag.

In a more general analysis, the H-WPT is an intrinsic phenomenon of harvester devices that rectify RF signals. In the spirit of green power, and particularly green RFID [50], further research efforts could be devoted to the use of the energy contained in these harmonics. In this context, the H-WPT can be rectified and used for ultra-low-power feeding.
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